



P-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(on)max}	I _D T _A = 25°C
-20V	16mΩ @ V _{GS} = -4.5V	-12.8A
-2UV	25mΩ @ V _{GS} = -2.0V	-10A

Description and Applications

This new generation MOSFET has been designed to minimize the onstate resistance ($R_{DS(on)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- DC-DC Converters
- Power management functions
- Notebook PC Applications
- Portable Equipment Applications

Features and Benefits

- Low On-Resistance
- Low Input Capacitance
- Low Input/Output Leakage
- ESD Protected Gate up to 2kV
- Lead Free by Design, RoHS Compliant (Note 1)
- "Green" Device (Note 2)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

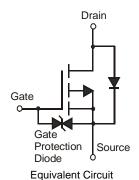
- Case: U-DFN2523-6
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu over Copper leadframe. Solderable per MIL-STD-202, Method 208
- Weight: 0.008 grams (approximate)



Pin 1, 2 = Source Pin 3 = Gate Pin 4, 5, 6 = Drain



Bottom View



Ordering Information (Note 3)

Part Number	Case	Packaging
DMP2018LFK-7	U-DFN2523-6	3,000 / Tape & Reel
DMP2018LFK-13	U-DFN2523-6	10,000 / Tape & Reel

Notes:

- 1. EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant. No purposely added lead. Halogen and Antimony free.
- 2. Diodes Inc.'s "Green" policy can be found on our website at http://www.diodes.com.
- 3. For packaging details, go to our website at http://www.diodes.com.

Marking Information



P8 = Product Type Marking Code YM = Date Code Marking Y = Year (ex: Y = 2011) M = Month (ex: 9 = September)

Date Code Key

Year	201	1	2012		2013	20	14	2015		2016		2017
Code	Υ		Z		Α		3	С		D		Е
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	1	5	6	7	Ω	٥	0	N	D

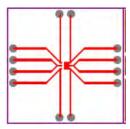


Characteristic		Symbol	Value	Units	
Drain-Source Voltage		V_{DSS}	-20	V	
Gate-Source Voltage			V_{GSS}	±12	V
Continuous Prain Correct (Note 5) V	Steady State	$T_A = 25$ °C $T_A = 70$ °C	I _D	-9.2 -7.3	А
Continuous Drain Current (Note 5) V _{GS} = -4.5V	t<5s	$T_A = 25$ °C $T_A = 70$ °C	I _D	-12.8 -10.3	А
Continuous Drain Current (Note 5) V _{GS} = -2.0V	Steady State	$T_A = 25$ °C $T_A = 70$ °C	l _D	-7.1 -6	А
Continuous Diain Curient (Note 5) VGS = -2.0V	t<5s	$T_A = 25$ °C $T_A = 70$ °C	I _D	-10 -8.3	А
Maximum Continuous Body Diode Forward Current	(Note 5)	Is	-3	Α	
Pulsed Drain Current (10μs pulse, duty cycle = 1%))	I_{DM}	-90	Α	
Avalanche Current (Note 6)	I _{AS}	17	A		
Repetitive Avalanche Energy (Note 6)		E _{AS}	72	mJ	

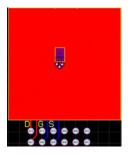
Thermal Characteristics

Characteristic		Symbol	Value	Units
Total Power Dissipation (Note 4)	$T_A = 25$ °C	c d	1	W
Total Power Dissipation (Note 4)	$T_A = 70$ °C	P _D	0.63	VV
Thermal Resistance, Junction to Ambient (Note 4)	Steady State		126	°C/W
Thermal Resistance, Junction to Ambient (Note 4)	t<5s	$R_{\theta JA}$	60	C/VV
Total Power Dissipation (Note 5)	$T_A = 25$ °C	Pn	2.1	W
Total Fower Dissipation (Note 3)	$T_A = 70$ °C	FD	1.3	V V
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	2	61	
Thermal Resistance, Junction to Ambient (Note 5)	t<5s	$R_{ heta JA}$	29	°C/W
Thermal Resistance, Junction to Case	·	$R_{ heta JC}$	6.4	
Operating and Storage Temperature Range		$T_{J_i}T_{STG}$	-55 to 150	°C

Notes: 4. Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.



Notes: 5. Device mounted on FR-4 substrate PC board, 2oz copper, with thermal vias to bottom layer 1inch square copper plate



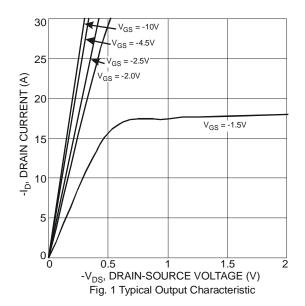


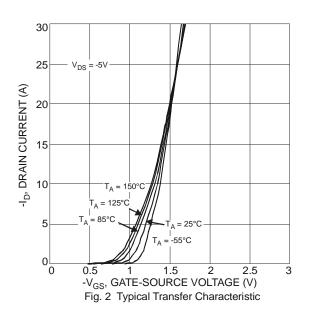
Electrical Characteristics @ T_A = 25°C unless otherwise stated

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV _{DSS}	-20	-	1	V	$V_{GS} = 0V, I_D = -10mA$	
Zero Gate Voltage Drain Current T _J = 25°C	I _{DSS}	-	-	-1	μΑ	$V_{DS} = -20V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	-	-	±2	μΑ	$V_{GS} = \pm 10V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	V _{GS(th)}	-0.45	-	-1.2	V	$V_{DS} = -10V, I_{D} = -200\mu A$	
		-	10	16		$V_{GS} = -4.5V$, $I_{D} = -3.6A$	
Static Drain-Source On-Resistance	В	-	12	20	$m\Omega$	$V_{GS} = -2.5V$, $I_D = -3.6A$	
Static Dialii-Source Off-Resistance	R _{DS (ON)}	-	13.6	25	11122	$V_{GS} = -2.0V, I_D = -1.8A$	
		-	20	-		V _{GS} = -1.5V, I _D = -1A	
Forward Transfer Admittance	Y _{fs}	10	17	-	S	$V_{DS} = -10V, I_D = -3.6A$	
Diode Forward Voltage	V _{SD}	-	0.7	1.2	V	V _{GS} = 0V, I _S = -3.6A	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	C _{iss}	-	4748	-		10)/)/ 0)/	
Output Capacitance	Coss	-	833	-	pF	$V_{DS} = -10V, V_{GS} = 0V,$ f = 1.0MHz	
Reverse Transfer Capacitance	C _{rss}	-	339	-		I = 1.0IVIH2	
Gate Resistance	Rg	-	6.2	-	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$	
Total Gate Charge (V _{GS} = -10V)	Qg	-	113	-			
Total Gate Charge (V _{GS} = -4.5V)	Qg	-	53	-	0	10/1 704	
Gate-Source Charge	Q _{qs}	-	7.1	-	nC	$V_{DS} = -16V, I_{D} = -7.2A$	
Gate-Drain Charge	Q_{qd}	-	8.5	-			
Turn-On Delay Time	t _{D(on)}	-	22.8	-			
Turn-On Rise Time	tr	-	29.8	-		$V_{DD} = -10V, V_{GS} = -4.5V,$	
Turn-Off Delay Time	t _{D(off)}	-	240.8	-	ns	$R_G = 4.7\Omega$, $I_D = -3.6A$	
Turn-Off Fall Time	t _f	-	100.6	1			

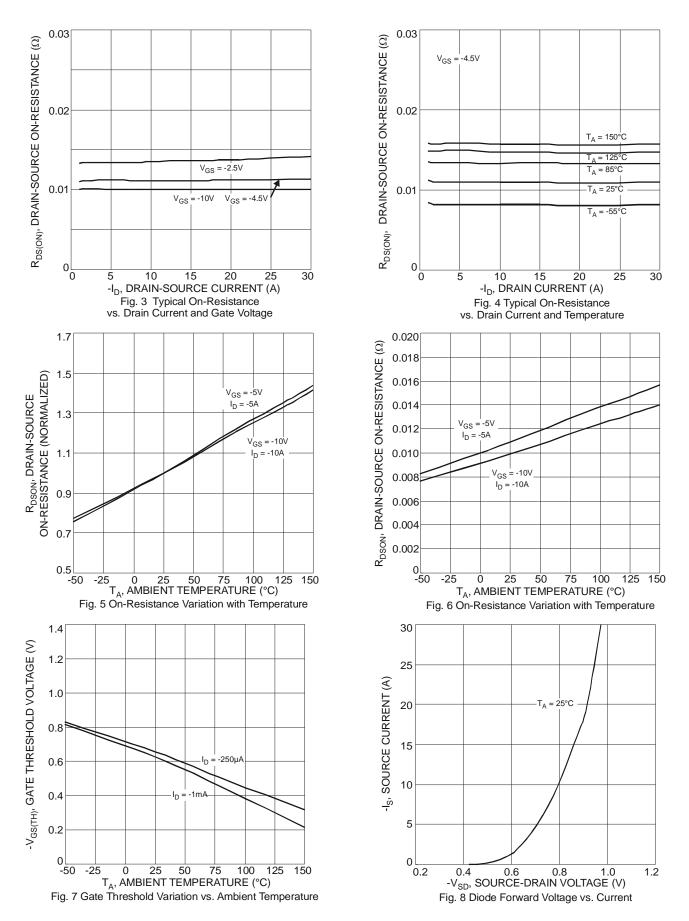
Notes:

- UIS in production with L = 0.5mH, TJ = 25°C
 Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to production testing.

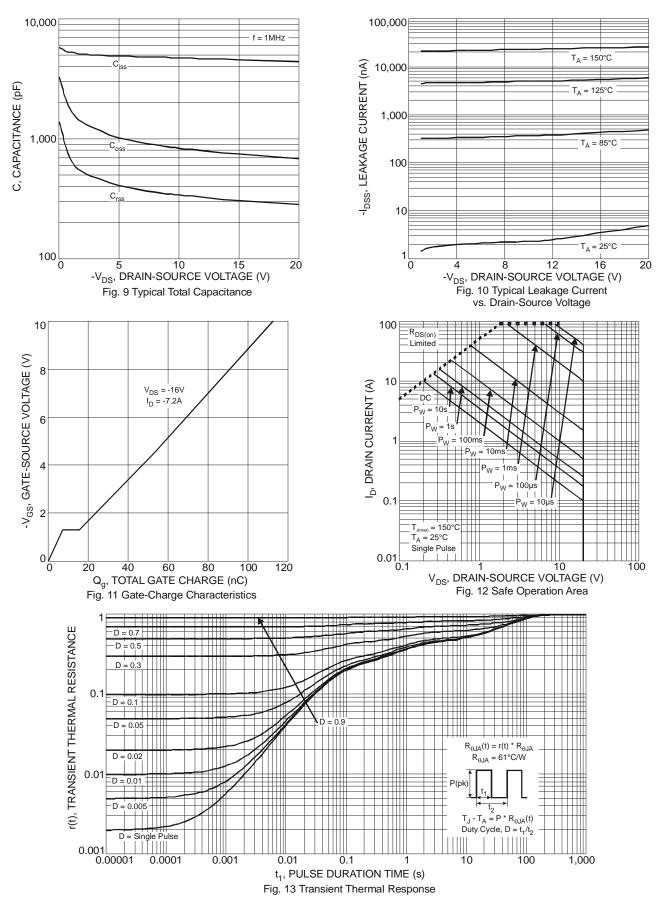






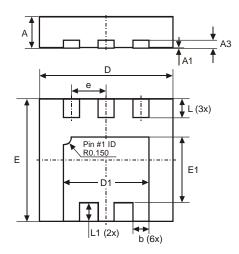






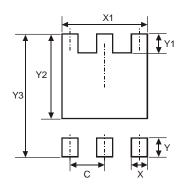


Package Outline Dimensions



U-DFN2523-6							
Dim	Min	Max	Тур				
Α	0.57	0.63	0.60				
A1	0	0.05	0.02				
А3	1	_	0.152				
b	0.25	0.35	0.30				
D	2.45	2.55	2.50				
D1	1.55	1.65	1.60				
е	_	_	0.65				
Е	2.25	2.35	2.30				
E1	1.18	1.28	1.23				
L	0.30	0.40	0.35				
L1	0.30	0.40	0.35				
All Dimensions in mm							

Suggested Pad Layout



Dimensions	Value (in mm)
С	0.650
Х	0.400
X1	1.700
Υ	0.650
Y1	0.450
Y2	1.830
Y3	2.700



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